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SHEET 1 of 2

Complete If Known			
Application Number	10/536,821		
Filing Date	5/27/2005		
First Named Inventor	Andrew D. Bankhead		
Art Unit	2875		
Examiner Name	Jonathan Hansen		
Attorney Docket No.	AMTH-101US		

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No.1	Document Number Number - Kind Code ^{2 (if known)}	Publication Date (MM-DD-YYYY)	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
/J.H./	1	US-10/507,837 (filed 5/23/05)	(1414-00-7777)	Bankhead et al.	, igu. es rippeo.
/J.H./	2	US-2003/0117632-A1	06-26-2003	Golini et al.	
/J.H./	3	US-6,552,806-B1	04-22-2003	Swinford et al.	
/J H /	4	US,6,545,761-B1	04-08-2003	Aziz et al.	
"/J.H./	5	US-2003/0011784-A1	01-16-2003	De Groot et al.	
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		Foreign Patent Document		Name of Patentee or	Pages, Columns, Lines, Where Relevant	
Examiner Initials*	Cite No.1	Country Code ³ - Number ⁴ - Kind Code ⁵ (If known)	Publication Date (MM-DD-YYYY)	Applicant of Cited Document	Passages or Relevant Figures Appear-	T6
/J.H./	20	WO-2004/048886-A1	06-10-2004	Taylor Hobson Limited		
/J.H./	21	WO-01/42735-A1	06-14-2001	Oti Opthalmic Technologies, Inc.		
/J.H./	22	WO-94/18523	08-18-1994	Zygo Corporation		
/J.H./	23	WO-93/16631	09-02-1993	Phoenix Laser Systems, Inc.		

Examiner Signature	/Jonathan Hansen/	Date Considered	06/26/2007

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Application Number	10/536,821	:
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First Named Inventor	Andrew Douglas	
Art Unit	2875	
Examiner Name	Jonathan Hansen	
Attorney Docket No.	AMTH-101US	

	NON-PATENT LITERATURE DOCUMENTS				
Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published	L ₅		
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